Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/821,923	OONISHI ET AL.	
Examiner	Art Unit	
 Lorna M. Douyon	1751	

SEARCHED					
Class	Subclass	Date	Examiner		
510	201	8/19/2006	LMD		
510	202	8/19/2006	LMD		
510	203	8/19/2006	LMD		
510	213	8/19/2006	LMD		
510	176	8/19/2006	LMD		
			:		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	8/19/2006	LMD	
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